

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/058,651	BLUMENAU, STEVEN M. ET AL	
	<b>Examiner</b>	<b>Art Unit</b>	
	Kyung H. Shin	2143	

## **Search Notes**



## **INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner